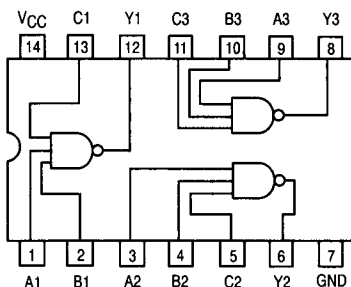




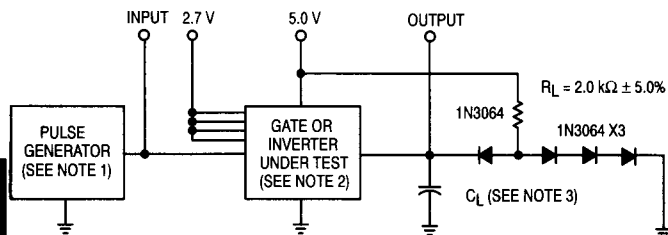
Triple 3-Input Positive NAND Gate

ELECTRICALLY TESTED PER:
MIL-M-38510/30005

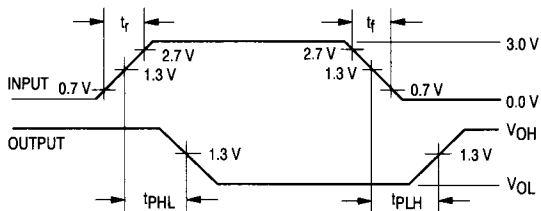
LOGIC DIAGRAM



AC TEST CIRCUIT



WAVEFORMS



NOTES:

1. Pulse generator has the following characteristics: $t_r \leq 15$ ns, $t_f \leq 6.0$ ns, $PRR \leq 1.0$ MHz, duty cycle = 50 % and $Z_{OUT} \approx 50 \Omega$.
2. Inputs not under test are at 2.7 V.
3. $C_L = 50$ pF $\pm 10\%$, including scope probe, wiring and stray capacitance.
4. $R_L = 2.0$ k $\Omega \pm 5.0\%$.
5. Voltage measurements are to be made with respect to network ground terminal.

Military 54LS10



AVAILABLE AS:

- 1) JAN: JM38510/30005BXA
- 2) SMD: N/A
- 3) 883: 54LS10/BXAJC

X = CASE OUTLINE AS FOLLOWS:
PACKAGE: CERDIP: C
CERFLAT: D
LCC: 2

THE LETTER "M" APPEARS
BEFORE THE / ON LCC.

PIN ASSIGNMENTS

FUNCT.	DIL 632-08	FLATS 717-04	LCC 756A-02	BURN-IN (COND. A)
A1	1	1	2	VCC
B1	2	2	3	GND
A2	3	3	4	VCC
B2	4	4	6	VCC
C2	5	5	8	GND
Y2	6	6	9	VCC
GND	7	7	10	GND
Y3	8	8	12	VCC
A3	9	9	13	VCC
B3	10	10	14	GND
C3	11	11	16	VCC
Y1	12	12	18	VCC
C1	13	13	19	GND
VCC	14	14	20	VCC

BURN-IN CONDITIONS:
 $V_{CC} = 5.0$ V MIN/6.0 V MAX

TRUTH TABLE

A	B	C	Y
0	0	0	0
0	0	1	1
0	1	0	1
0	1	1	1
1	0	0	1
1	0	1	1
1	1	0	1
1	1	1	1

54LS10

Symbol	Parameter	Limits						Unit	Test Condition (Unless Otherwise Specified)
	Static Parameters:	+ 25°C		+ 125°C		- 55°C			
		Subgroup 1		Subgroup 2		Subgroup 3			
		Min	Max	Min	Max	Min	Max		
V _{OH}	Logical "1" Output Voltage	2.5		2.5		2.5		V	V _{CC} = 4.5 V, I _{OH} = - 400 μA, V _{IL} = 0.7 V, V _{IN} = 5.5 V on other input.
V _{OL}	Logical "0" Output Voltage		0.4		0.4		0.4	V	V _{CC} = 4.5 V, I _{OL} = 4.0 mA, V _{IH} = 2.0 V, on all inputs.
V _{IC}	Input Clamping Voltage		- 1.5					V	V _{CC} = 4.5 V, I _{IN} = -18 mA, other inputs are open.
I _{IH1}	Logical "1" Input Current		20		20		20	μA	V _{CC} = 5.5 V, V _{IN} = 2.7 V, other inputs = 0 V.
I _{IH2}	Logical "1" Input Current		100		100		100	μA	V _{CC} = 5.5 V, V _{IN} = 5.5 V, other inputs = 0 V.
I _{IL}	Logical "0" Input Current	- 160	- 400	- 160	- 400	- 160	- 400	μA	V _{CC} = 5.5 V, V _{IN} = 0.4 V, other inputs = 5.5 V.
I _{OS}	Output Short Circuit Current	- 15	- 100	- 15	- 100	- 15	- 100	mA	V _{CC} = 5.5 V, V _{IN} = 0 V (all inputs), V _{OUT} = 0 V.
I _{CCH}	Power Supply Current		1.2		1.2		1.2	mA	V _{CC} = 5.5 V, V _{IN} = 0 V (all inputs).
I _{CCL}	Power Supply Current		3.3		3.3		3.3	mA	V _{CC} = 5.5 V, V _{IN} = 5.5 V (all inputs).
V _{IH}	Logical "1" Input Voltage	2.0		2.0		2.0		V	V _{CC} = 4.5 V.
V _{IL}	Logical "0" Input Voltage		0.7		0.7		0.7	V	V _{CC} = 4.5 V.
	Functional Tests	Subgroup 7		Subgroup 8A		Subgroup 8B			per Truth Table with V _{CC} = 5.0 V, V _{INL} = 0.5 V, and V _{INH} = 2.5 V.

Symbol	Parameter	Limits						Unit	Test Condition (Unless Otherwise Specified)
	Switching Parameters:	+ 25°C		+ 125°C		− 55°C			
		Subgroup 9		Subgroup 10		Subgroup 11			
		Min	Max	Min	Max	Min	Max		
t _{PHL} t _{PHL}	Propagation Delay /Data-Output Output <u>High-Low</u>	2.0 —	17 15	2.0 —	24 19	2.0 —	24 19	ns	V _{CC} = 5.0 V, C _L = 50 pF, R _L = 2.0 kΩ. V _{CC} = 5.0 V, C _L = 15 pF, R _L = 2.0 kΩ.
t _{PLH} t _{PLH}	Propagation Delay /Data-Output Output <u>Low-High</u>	2.0 —	15 15	2.0 —	20 15	2.0 —	20 15	ns	V _{CC} = 5.0 V, C _L = 50 pF, R _L = 2.0 kΩ. V _{CC} = 5.0 V, C _L = 15 pF, R _L = 2.0 kΩ.

NOTE:

NOTE:

- The limits specified for C_L = 15 pF are guaranteed but not tested.